

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/737,190	SHIBUYA, TETSUO	
Examiner	Art Unit	
Cheyne D. Ly	1631	

	SEARCHED					
Class	Subclass	Date	Examiner			
updated	updated	5/24/2005	CDL			
702	19,20,27	5/24/06	on			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
702	20	5/24/06	spe		
702	19,29	5/24/06	coc		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN and EAST: array, suffix tree, location, chaning array, replace, compare, and traversing	5/24/2005	col		
updaled: FAST PALM inventor Seach	3 ky/06			
A primary accominatellist had been consulted in regard to the pollowed of this application.	5/3/66	cM		